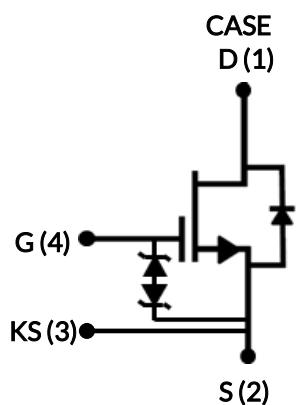


## DATASHEET

# UF3SC065007K4S



Part Number	Package	Marking
UF3SC065007K4S	TO-247-4L	UF3SC065007K4S



## 650V-6.7mΩ SiC FET

Rev. B, December 2019

### Description

This SiC FET device is based on a unique ‘cascode’ circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device’s standard gate-drive characteristics allows for a true “drop-in replacement” to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-4L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads , and any application requiring standard gate drive.

### Features

- ◆ Typical on-resistance  $R_{DS(on),typ}$  of 6.7mΩ
- ◆ Maximum operating temperature of 175°C
- ◆ Excellent reverse recovery
- ◆ Low gate charge
- ◆ Low intrinsic capacitance
- ◆ ESD protected, HBM class 2
- ◆ TO-247-4L package for faster switching, clean gate waveforms

### Typical applications

- ◆ EV charging
- ◆ PV inverters
- ◆ Switch mode power supplies
- ◆ Power factor correction modules
- ◆ Motor drives
- ◆ Induction heating

## Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	$V_{DS}$		650	V
Gate-source voltage	$V_{GS}$	DC	-20 to +20	V
Continuous drain current <sup>1</sup>	$I_D$	$T_C < 135^\circ C$	120	A
Pulsed drain current <sup>2</sup>	$I_{DM}$	$T_C = 25^\circ C$	550	A
Single pulsed avalanche energy <sup>3</sup>	$E_{AS}$	$L=15mH, I_{AS}=8.6A$	555	mJ
Power dissipation	$P_{tot}$	$T_C = 25^\circ C$	789	W
Maximum junction temperature	$T_{J,max}$		175	$^\circ C$
Operating and storage temperature	$T_J, T_{STG}$		-55 to 175	$^\circ C$
Max. lead temperature for soldering, 1/8" from case for 5 seconds	$T_L$		250	$^\circ C$

1. Limited by bondwires
2. Pulse width  $t_p$  limited by  $T_{J,max}$
3. Starting  $T_J = 25^\circ C$

## Thermal Characteristics

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.15	0.19	$^\circ C/W$

## Electrical Characteristics ( $T_J = +25^\circ\text{C}$ unless otherwise specified)

### Typical Performance - Static

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Drain-source breakdown voltage	$\text{BV}_{\text{DS}}$	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=1\text{mA}$	650			V
Total drain leakage current	$\text{I}_{\text{DSS}}$	$\text{V}_{\text{DS}}=650\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{T}_J=25^\circ\text{C}$		7	600	$\mu\text{A}$
		$\text{V}_{\text{DS}}=650\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{T}_J=175^\circ\text{C}$		70		
Total gate leakage current	$\text{I}_{\text{GSS}}$	$\text{V}_{\text{DS}}=0\text{V}, \text{T}_J=25^\circ\text{C}, \text{V}_{\text{GS}}=-20\text{V} / +20\text{V}$		5	$\pm 20$	$\mu\text{A}$
Drain-source on-resistance	$\text{R}_{\text{DS(on)}}$	$\text{V}_{\text{GS}}=12\text{V}, \text{I}_D=50\text{A}, \text{T}_J=25^\circ\text{C}$		6.7	9	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=12\text{V}, \text{I}_D=50\text{A}, \text{T}_J=125^\circ\text{C}$		8.8		
		$\text{V}_{\text{GS}}=12\text{V}, \text{I}_D=50\text{A}, \text{T}_J=175^\circ\text{C}$		11		
Gate threshold voltage	$\text{V}_{\text{G(th)}}$	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=10\text{mA}$	4	4.7	6	V
Gate resistance	$\text{R}_G$	f=1MHz, open drain		0.8	1.5	$\Omega$

### Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Diode continuous forward current <sup>1</sup>	$\text{I}_S$	$\text{T}_C < 135^\circ\text{C}$			120	A
Diode pulse current <sup>2</sup>	$\text{I}_{\text{S,pulse}}$	$\text{T}_C=25^\circ\text{C}$			550	A
Forward voltage	$\text{V}_{\text{FSD}}$	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_F=80\text{A}, \text{T}_J=25^\circ\text{C}$		1.31	1.5	V
		$\text{V}_{\text{GS}}=0\text{V}, \text{I}_F=80\text{A}, \text{T}_J=175^\circ\text{C}$		1.4		
Reverse recovery charge	$\text{Q}_{\text{rr}}$	$\text{V}_R=400\text{V}, \text{I}_F=80\text{A}, \text{V}_{\text{GS}}=-5\text{V}, \text{R}_{\text{G,EXT}}=10\Omega, \text{di}/\text{dt}=1400\text{A}/\mu\text{s}, \text{T}_J=25^\circ\text{C}$		856		nC
Reverse recovery time	$\text{t}_{\text{rr}}$			53		
Reverse recovery charge	$\text{Q}_{\text{rr}}$	$\text{V}_R=400\text{V}, \text{I}_F=80\text{A}, \text{V}_{\text{GS}}=-5\text{V}, \text{R}_{\text{G,EXT}}=10\Omega, \text{di}/\text{dt}=1400\text{A}/\mu\text{s}, \text{T}_J=150^\circ\text{C}$		865		nC
Reverse recovery time	$\text{t}_{\text{rr}}$			35		

## Typical Performance - Dynamic

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Input capacitance	$C_{iss}$	$V_{DS}=100V, V_{GS}=0V$ $f=100kHz$		8360		pF
Output capacitance	$C_{oss}$			1190		
Reverse transfer capacitance	$C_{rss}$			11.3		
Effective output capacitance, energy related	$C_{oss(er)}$	$V_{DS}=0V$ to 400V, $V_{GS}=0V$		856		pF
Effective output capacitance, time related	$C_{oss(tr)}$	$V_{DS}=0V$ to 400V, $V_{GS}=0V$		1806		pF
$C_{oss}$ stored energy	$E_{oss}$	$V_{DS}=400V, V_{GS}=0V$		69		$\mu J$
Total gate charge	$Q_G$	$V_{DS}=400V, I_D=80A,$ $V_{GS} = -5V$ to 15V		214		nC
Gate-drain charge	$Q_{GD}$			28		
Gate-source charge	$Q_{GS}$			96		
Turn-on delay time	$t_{d(on)}$	$V_{DS}=400V, I_D=80A$ , Gate Driver =-5V to +15V, Turn-on $R_{G,EXT}=1.5\Omega$ , Turn-off $R_{G,EXT}=5\Omega$ Inductive Load, FWD: same device with $V_{GS} = -5V, R_G = 10\Omega, T_J=25^\circ C$		36		ns
Rise time	$t_r$			46		
Turn-off delay time	$t_{d(off)}$			72		
Fall time	$t_f$			14		
Turn-on energy	$E_{ON}$			925		$\mu J$
Turn-off energy	$E_{OFF}$			83		
Total switching energy	$E_{TOTAL}$			1008		
Turn-on delay time	$t_{d(on)}$	$V_{DS}=400V, I_D=80A$ , Gate Driver =-5V to +15V, Turn-on $R_{G,EXT}=1.5\Omega$ , Turn-off $R_{G,EXT}=5\Omega$ Inductive Load, FWD: same device with $V_{GS} = -5V, R_G = 10\Omega, T_J=150^\circ C$		38		ns
Rise time	$t_r$			47		
Turn-off delay time	$t_{d(off)}$			75		
Fall time	$t_f$			14		
Turn-on energy	$E_{ON}$			1081		$\mu J$
Turn-off energy	$E_{OFF}$			105		
Total switching energy	$E_{TOTAL}$			1186		

## Typical Performance - Dynamic (continued)

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Turn-on delay time	$t_{d(on)}$	$V_{DS}=400V, I_D=80A, \text{Gate Driver } =-5V \text{ to } +15V, \text{ Turn-on } R_{G,EXT}=1.5\Omega, \text{ Turn-off } R_{G,EXT}=5\Omega, \text{ Inductive Load, FWD: UJ3D065030TS } T_J=25^\circ C$		36		ns
Rise time	$t_r$			37		
Turn-off delay time	$t_{d(off)}$			72		
Fall time	$t_f$			14		
Turn-on energy	$E_{ON}$			545		
Turn-off energy	$E_{OFF}$			82		
Total switching energy	$E_{TOTAL}$			627		
Turn-on delay time	$t_{d(on)}$	$V_{DS}=400V, I_D=80A, \text{Gate Driver } =-5V \text{ to } +15V, \text{ Turn-on } R_{G,EXT}=1.5\Omega, \text{ Turn-off } R_{G,EXT}=5\Omega, \text{ Inductive Load, FWD:UJ3D065030TS } T_J=150^\circ C$		34		ns
Rise time	$t_r$			40		
Turn-off delay time	$t_{d(off)}$			79		
Fall time	$t_f$			14		
Turn-on energy	$E_{ON}$			555		
Turn-off energy	$E_{OFF}$			84		
Total switching energy	$E_{TOTAL}$			639		

## Typical Performance Diagrams

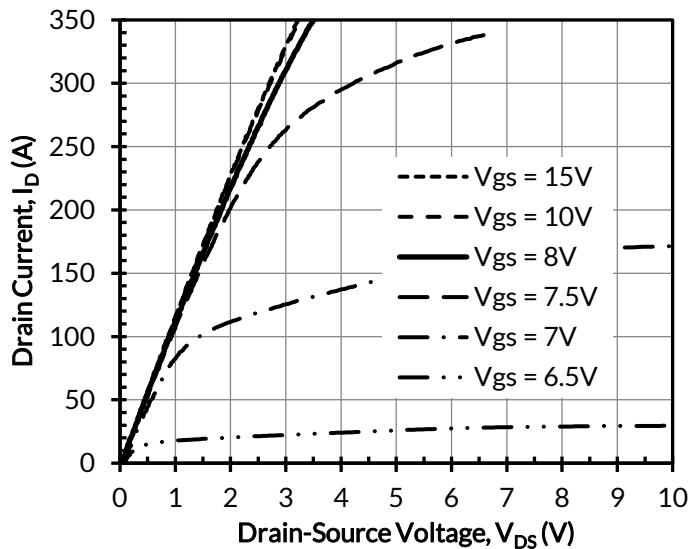


Figure 1. Typical output characteristics at  $T_J = -55^\circ\text{C}$ ,  $t_p < 250\mu\text{s}$

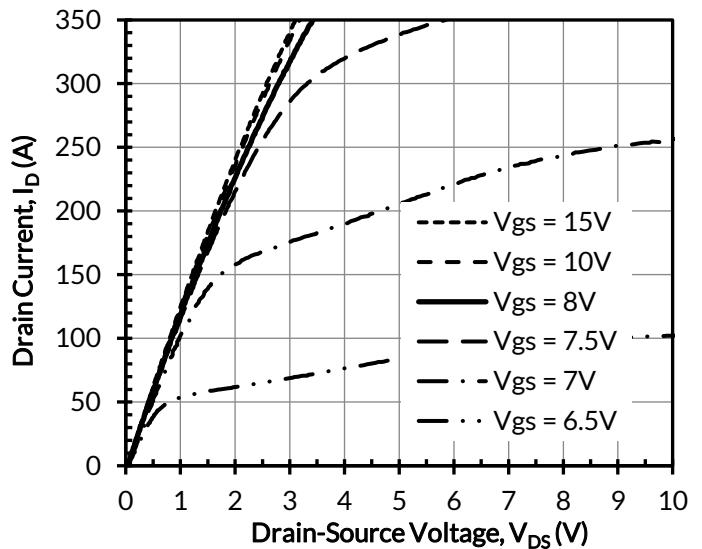


Figure 2. Typical output characteristics at  $T_J = 25^\circ\text{C}$ ,  $t_p < 250\mu\text{s}$

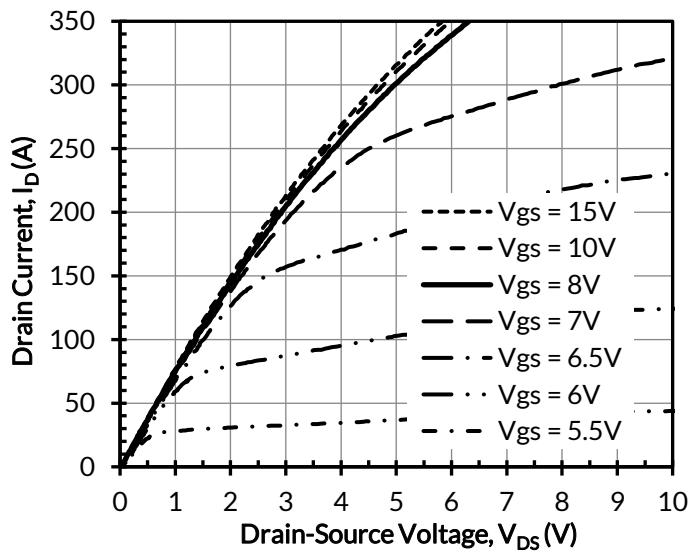


Figure 3. Typical output characteristics at  $T_J = 175^\circ\text{C}$ ,  $t_p < 250\mu\text{s}$

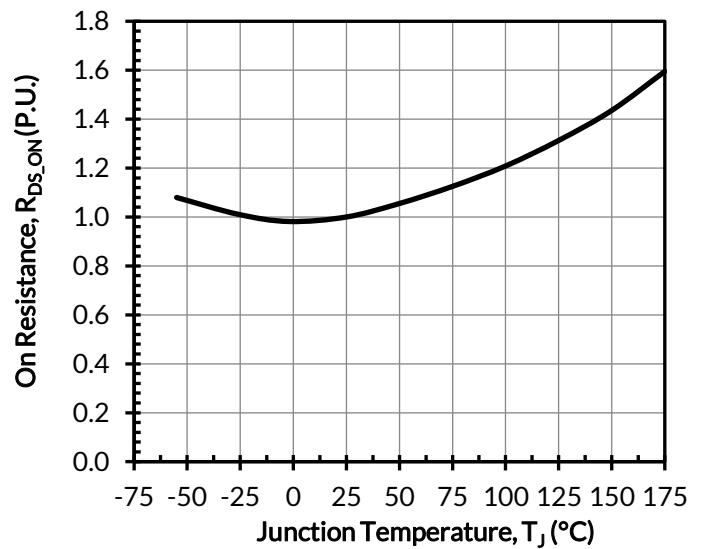


Figure 4. Normalized on-resistance vs. temperature at  $V_{GS} = 12V$  and  $I_D = 50A$

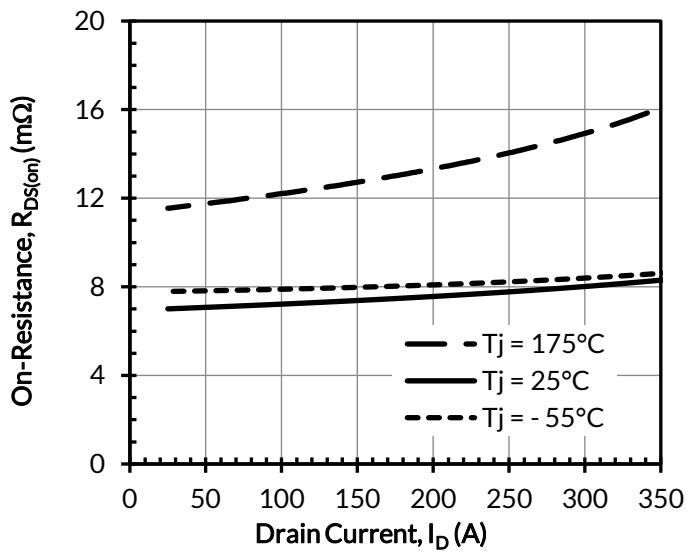


Figure 5. Typical drain-source on-resistances at  $V_{GS} = 12\text{V}$

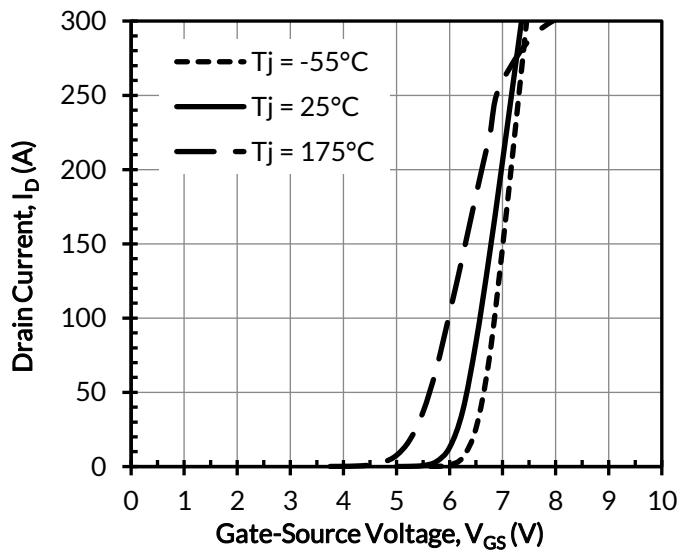


Figure 6. Typical transfer characteristics at  $V_{DS} = 5\text{V}$

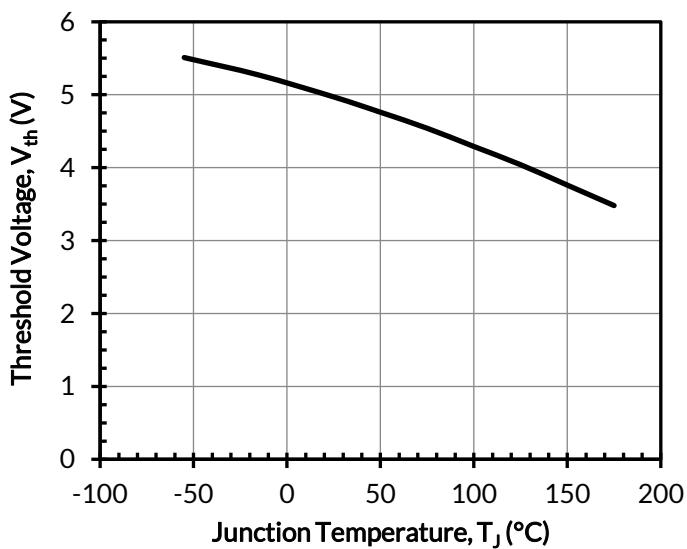


Figure 7. Threshold voltage vs. junction temperature at  $V_{DS} = 5\text{V}$  and  $I_D = 10\text{mA}$

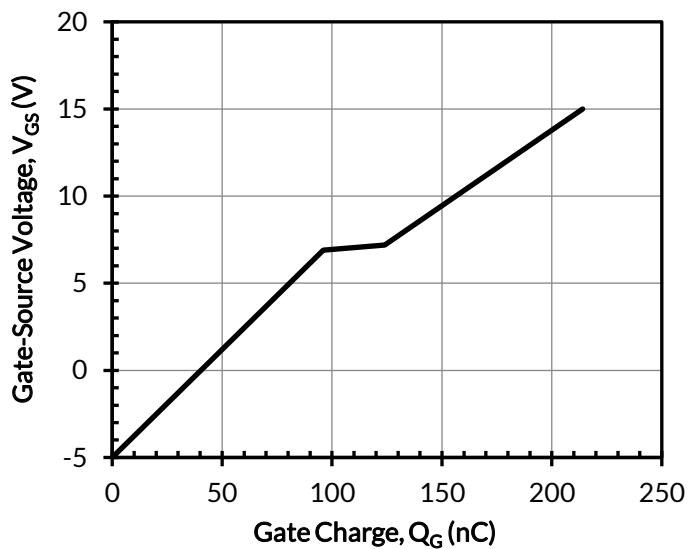


Figure 8. Typical gate charge at  $V_{DS} = 800\text{V}$  and  $I_D = 80\text{A}$

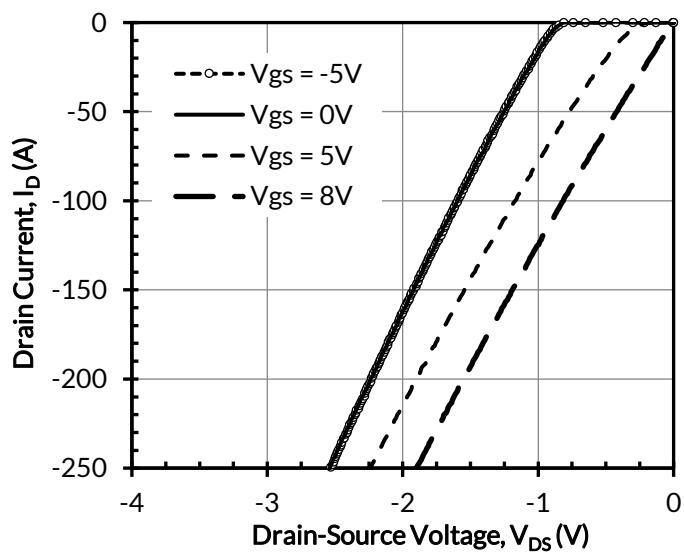


Figure 9. 3rd quadrant characteristics at  $T_J = -55^\circ\text{C}$

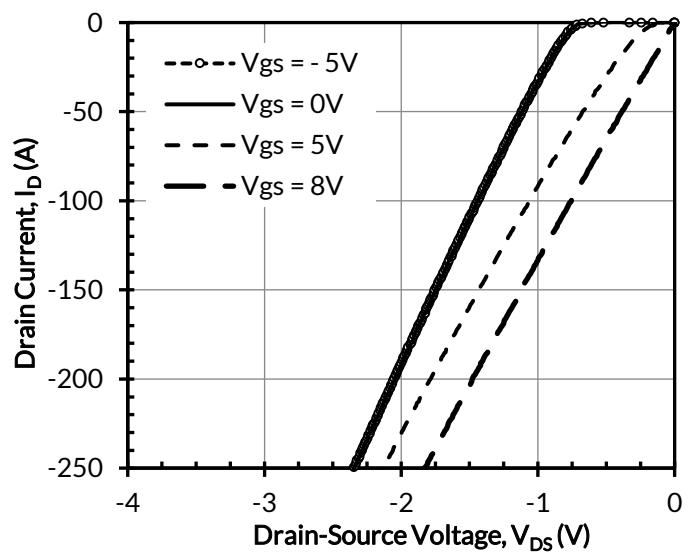


Figure 10. 3rd quadrant characteristics at  $T_J = 25^\circ\text{C}$

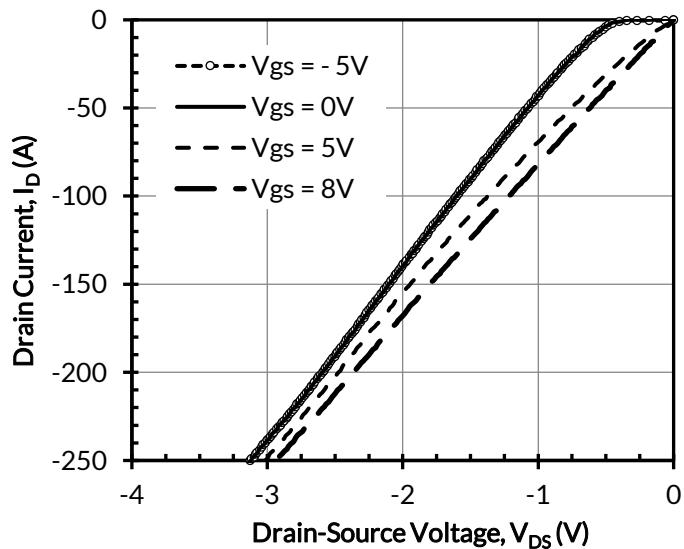


Figure 11. 3rd quadrant characteristics at  $T_J = 175^\circ\text{C}$

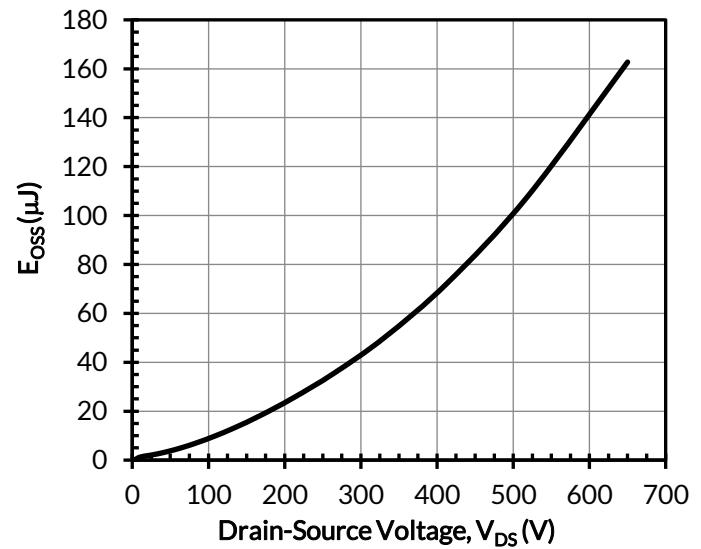


Figure 12. Typical stored energy in  $C_{OSS}$  at  $V_{GS} = 0\text{V}$

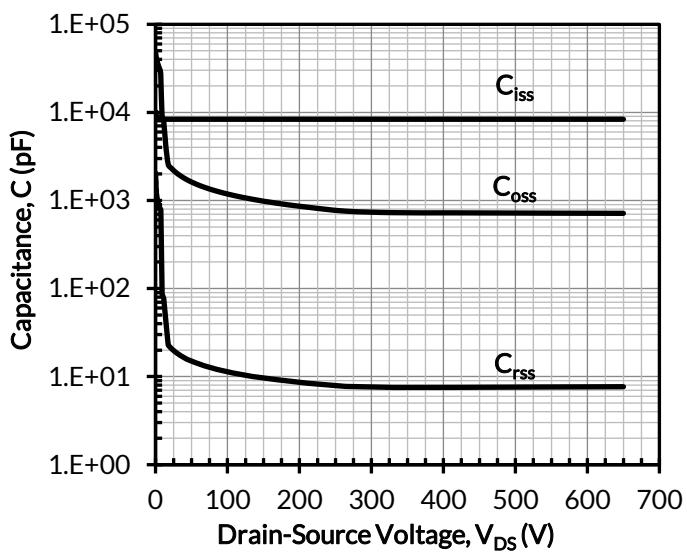


Figure 13. Typical capacitances at  $f = 100\text{kHz}$  and  $V_{GS} = 0\text{V}$

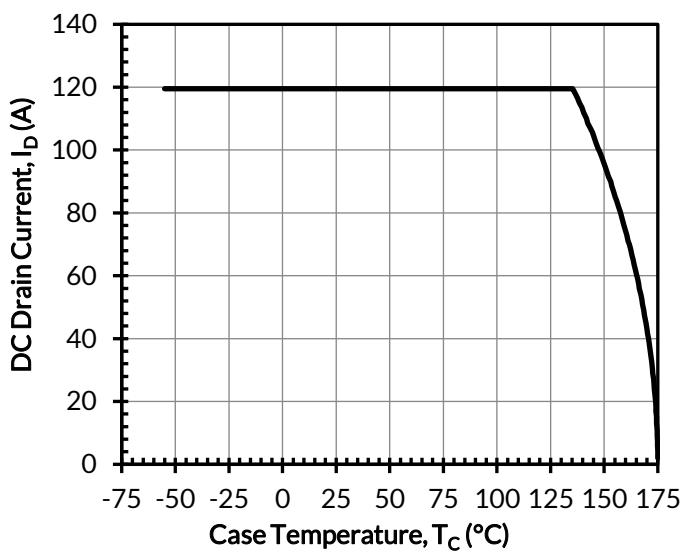


Figure 14. DC drain current derating

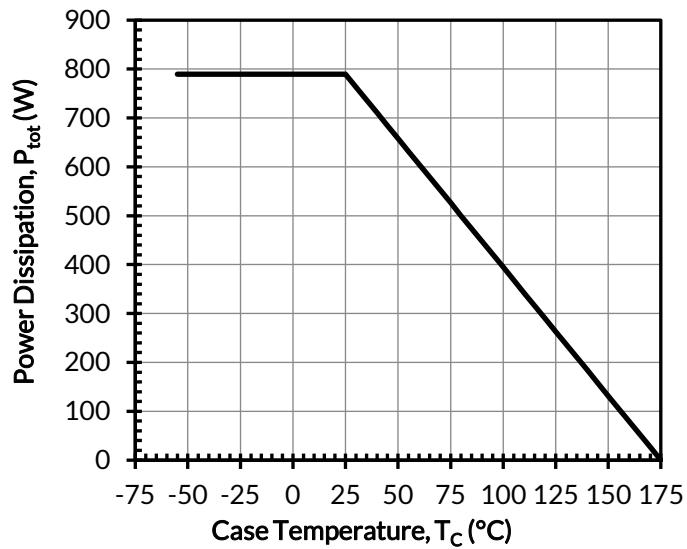


Figure 15. Total power dissipation

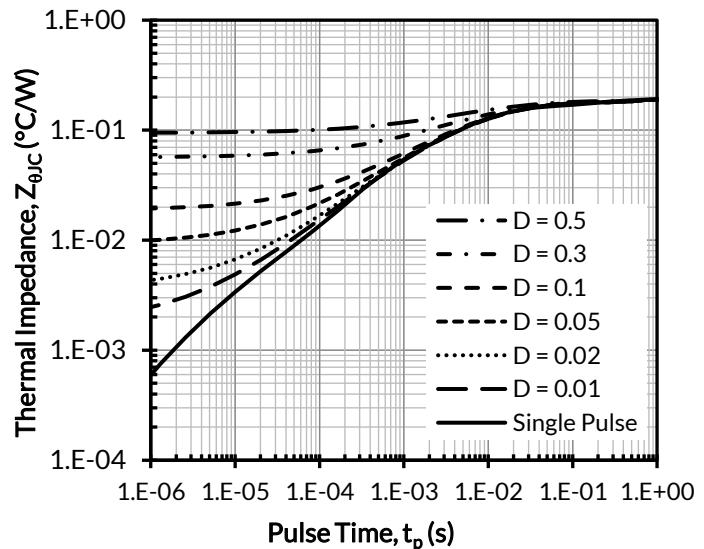


Figure 16. Maximum transient thermal impedance

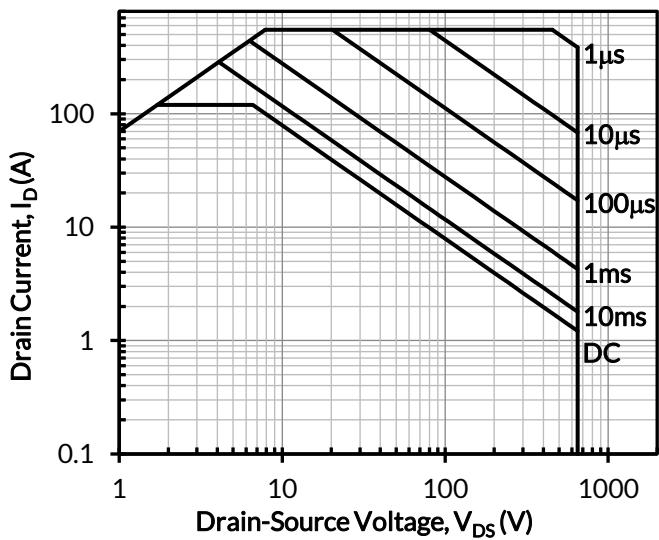


Figure 17. Safe operation area at  $T_C = 25^\circ\text{C}$ ,  $D = 0$ , Parameter  $t_p$

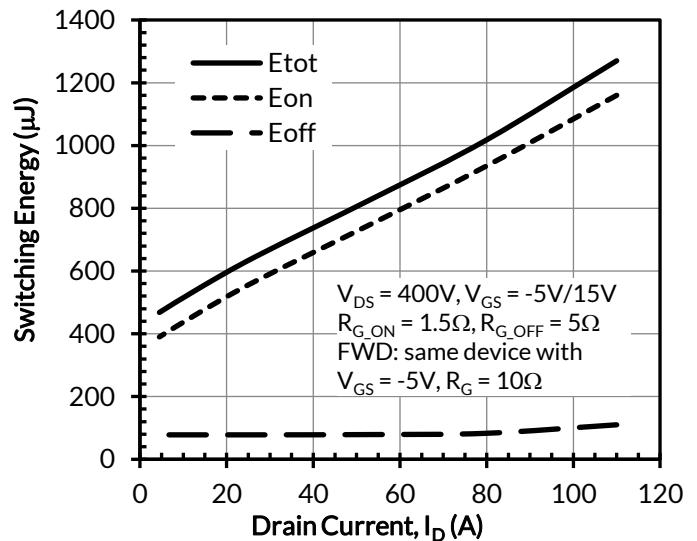


Figure 18. Clamped inductive switching energy vs. drain current at  $T_J = 25^\circ\text{C}$

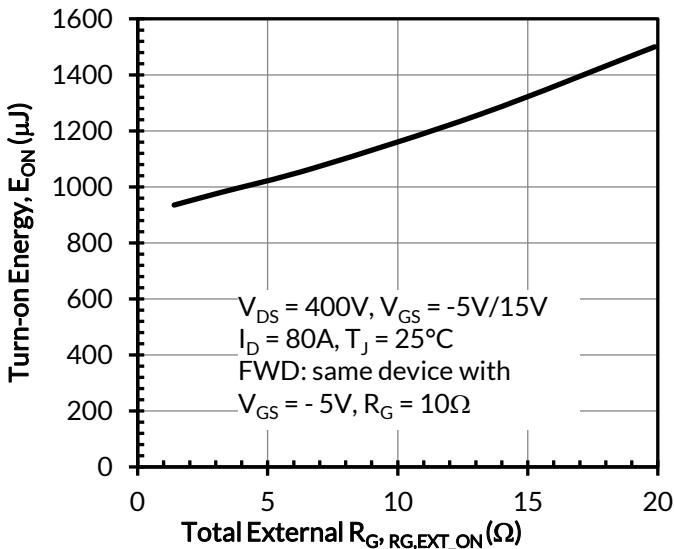


Figure 19. Clamped inductive switching turn-on energy vs.  $R_{G,ext\_on}$

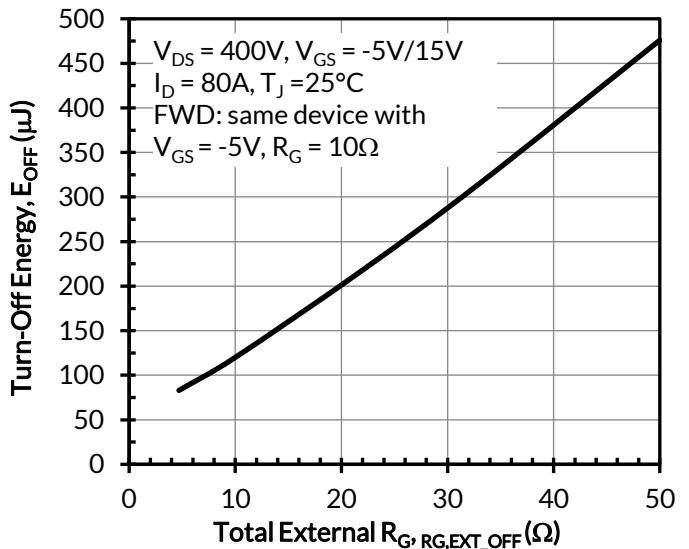


Figure 20. Clamped inductive switching turn-off energy vs.  $R_{G,ext\_off}$

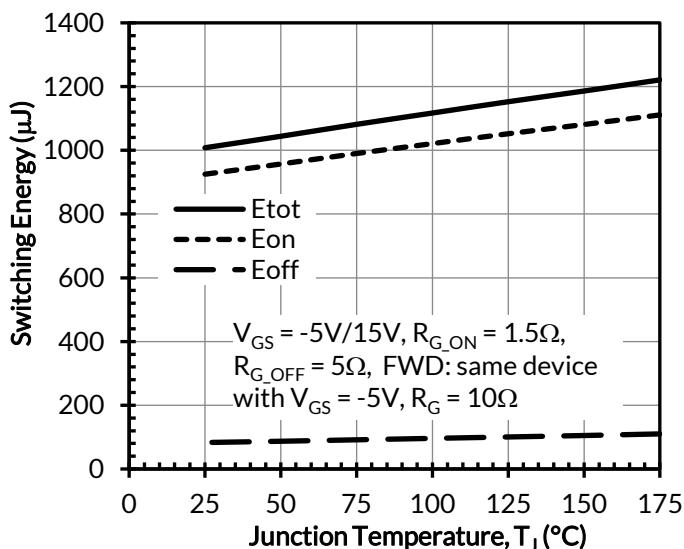


Figure 21. Clamped inductive switching energy vs. junction temperature at  $V_{DS} = 400V$  and  $I_D = 80A$

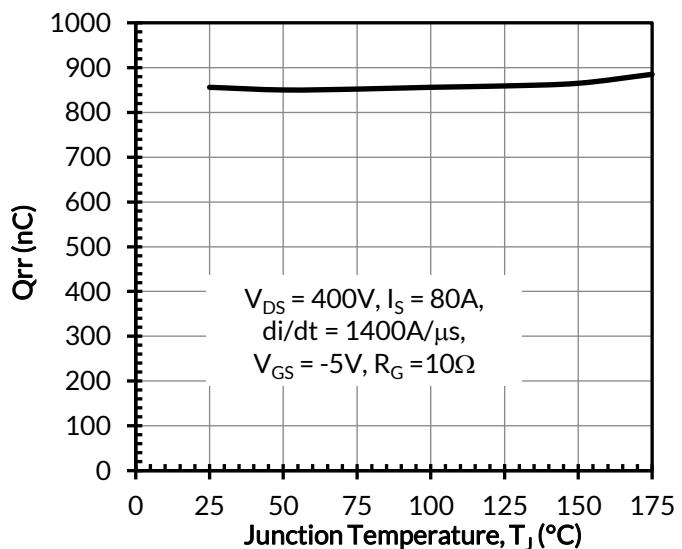


Figure 22. Reverse recovery charge  $Q_{rr}$  vs. junction temperature

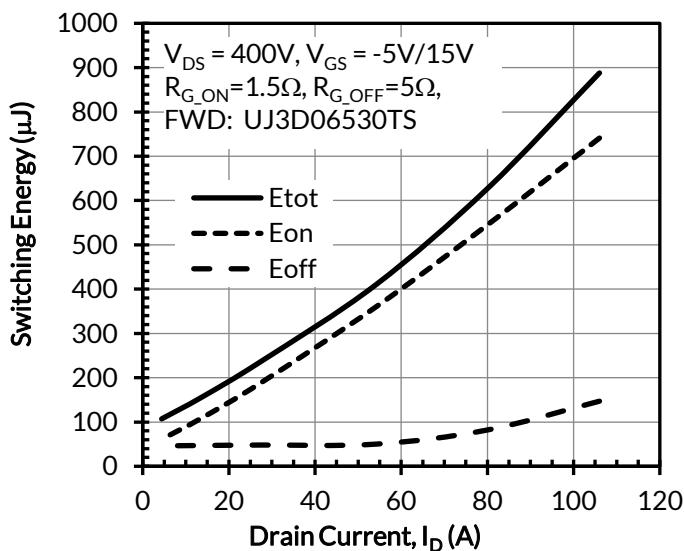


Figure 23. Clamped inductive switching energy vs. drain current at  $T_J = 25^\circ C$

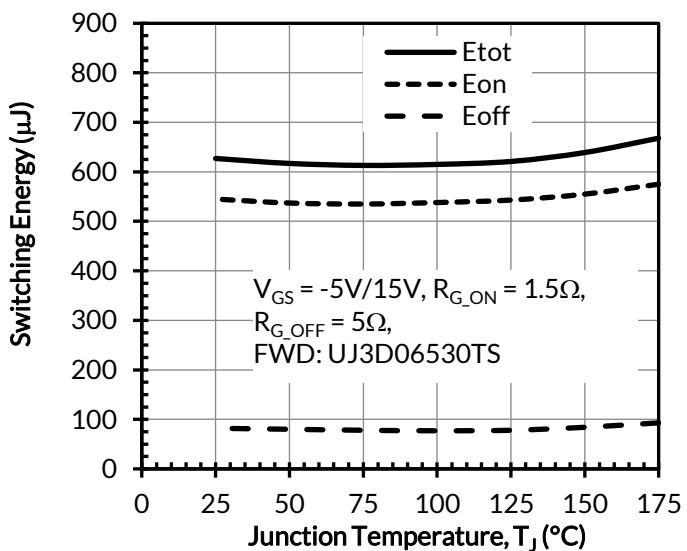


Figure 24. Clamped inductive switching energy vs. junction temperature at  $V_{DS} = 400V$  and  $I_D = 80A$